STP80NF12



N-channel 120 V, 0.013 Ω typ., 80 A, STripFET™ II Power MOSFET in a TO-220 package

Datasheet - production data

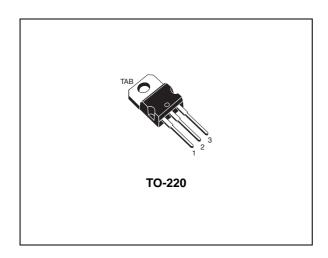
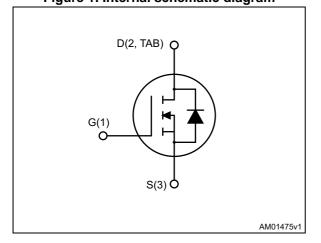


Figure 1. Internal schematic diagram



Features

Туре	V _{DSS}	R _{DS(on)} max	I _D
STP80NF12	120 V	< 0.018 Ω	80 A

- Exceptional dv/dt capability
- 100% avalanche tested
- · Application oriented characterization

Application

• Switching applications

Description

This MOSFET series realized with STMicroelectronics unique STripFET process has specifically been designed to minimize input capacitance and gate charge. It is therefore suitable as primary switch in advanced highefficiency, high-frequency isolated DC-DC converters for telecom and computer applications. It is also intended for any applications with low gate drive requirements.

Table 1. Device summary

Order code	Order code Marking Package		Packaging
STP80NF12	P80NF12	TO-220	Tube

Contents STP80NF12

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STP80NF12 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	120	V
V _{GS}	Gate-source voltage	± 20	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25 °C	80	Α
I _D	Drain current (continuous) at T _C =100 °C	60	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	320	Α
P _{TOT}	Total dissipation at T _C = 25 °C	300	W
	Derating factor	2.0	W/°C
dv/dt (3)	Peak diode recovery voltage slope	10	V/ns
E _{AS} (4)	Single pulse avalanche energy	350	mJ
T _J T _{stg}	Operating junction temperature Storage temperature	-55 to 175	°C

^{1.} Limited by package

- 2. Pulse width limited by safe operating area
- 3. I_{SD} < 80 A, di/dt < 300 A/ μ s, V_{DD} = 80% $V_{(BR)DSS}$
- 4. Starting $T_J = 25$ °C, $I_D = 40$ A, $V_{DD} = 50$ V

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thJC}	Thermal resistance junction-case max	0.5	°C/W
R _{thJA}	Thermal resistance junction-ambient max	62.5	°C/W
T _I	Maximum lead temperature for soldering purpose	300	°C

Electrical characteristics STP80NF12

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 250 \mu\text{A}, V_{GS} = 0$	120			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = max rating V_{DS} = max rating @125°C			1 10	μΑ μΑ
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ±20 V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2		4	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10 V, I _D = 40 A		0.013	0.018	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	$V_{DS} = 15 \text{ V}, I_{D} = 40 \text{ A}$	-	80		S
C _{iss}	Input capacitance		-	4300		pF
C _{oss}	Output capacitance	V _{DS} =25 V, f=1 MHz,	-	600		pF
C _{rss}	Reverse transfer capacitance	V _{GS} =0	-	230		pF
Q _{gs}	Total gate charge	V 00 V I 00 A	-	140	189	nC
Q _{gs}	Gate-source charge	$V_{DD} = 80 \text{ V}, I_{D} = 80 \text{ A}$ $V_{GS} = 10 \text{ V}$	-	23		nC
Q_{gd}	Gate-drain charge	165	-	51		nC

^{1.} Pulsed: pulse duration=300µs, duty cycle 1.5%

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time		-	40	-	ns
t _r	Rise time	V_{DD} = 50 V, I_{D} = 40 A, R_{G} =4.7 Ω , V_{GS} =10 V	-	145	-	ns
t _{d(off)}	Turn-off delay time	See Figure 13	-	134	-	ns
t _f	Fall time		-	115	-	ns



Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
I _{SD}	Source-drain current		-	-	80	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-	-	320	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} =80 A, V _{GS} =0	-	-	1.3	V
t _{rr}	Reverse recovery time	I _{SD} =80 A,	-	155		ns
Q _{rr}	Reverse recovery charge	di/dt = 100 A/µs,	-	0.85		μC
I _{RRM}	Reverse recovery current	$V_{DD} = 35 \text{ V, T}_{J} = 150 ^{\circ}\text{C}$	-	11		Α

^{1.} Pulse width limited by safe operating area

^{2.} Pulsed: pulse duration = $300 \mu s$, duty cycle 1.5%

Electrical characteristics STP80NF12

Electrical characteristics (curves) 2.1

Figure 2. Safe operating area

lo(A) 10².

Figure 3. Thermal impedance

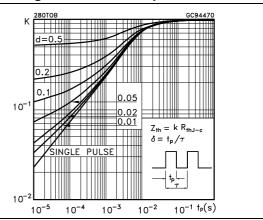


Figure 4. Output characteristics

lo(A) 160 Vgs=10V 7۷ 120 80 40

Figure 5. Transfer characteristics

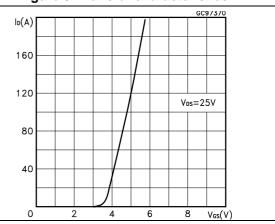


Figure 6. Normalized B_{VDSS} vs. temperature

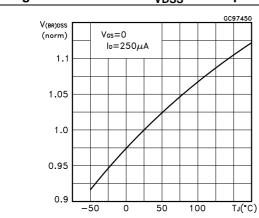
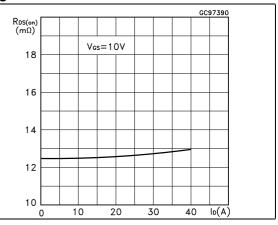


Figure 7. Static drain-source on resistance



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Figure 8. Gate charge vs. gate-source voltage

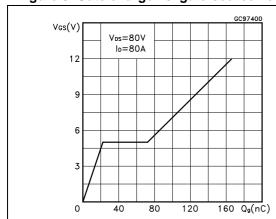


Figure 9. Capacitance variations

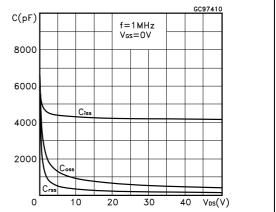
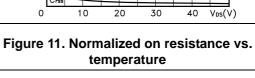
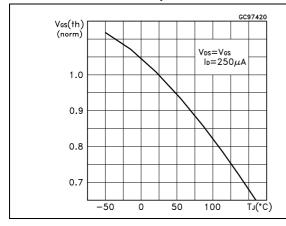


Figure 10. Normalized gate threshold voltage vs. temperature





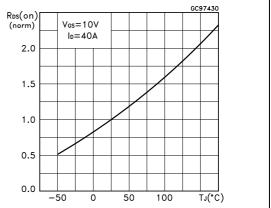
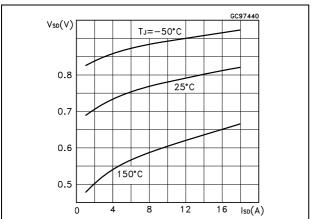


Figure 12. Source-drain diode forward characteristics



Test circuits STP80NF12

3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

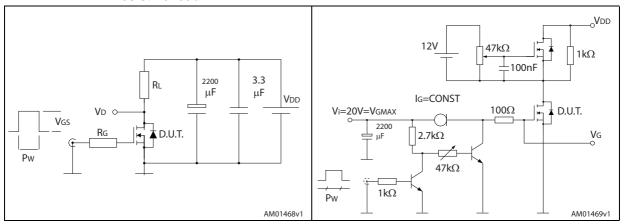


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped inductive load test circuit

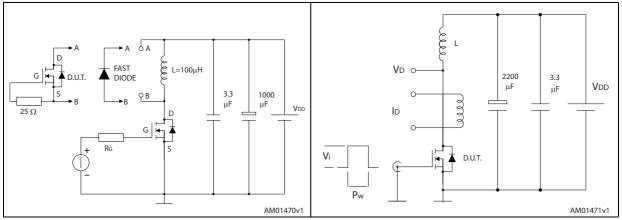
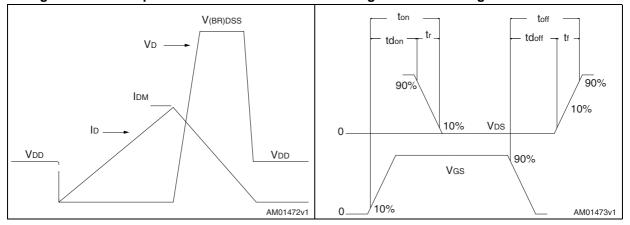


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



4 Package mechanical data

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øΡ Ε H1 D <u>D1</u> L20 L30 <u>L</u>1 b1(X3) -- *b (ХЗ)* _e 1__ 0015988_typeA_Rev_T

Figure 19. TO-220 type A drawing



Table 8. TO-220 type A mechanical data

Di		mm	
Dim.	Min.	Тур.	Max.
А	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
С	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
е	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95



Revision history STP80NF12

5 Revision history

Table 9. Revision history

Date	Revision	Changes
21-Jun-2004	2	Preliminary version
24-Jul-2006	3	The document has been reformatted, SOA updated
31-Jan-2007	4	Typo mistake on <i>Table 2</i> .
10-Apr-2007	5	Typo mistake on Table 2 and Table 3
19-Apr-2007	6	Corrected value on Table 4
17-Nov-2008	7	Inserted E _{AS} value on <i>Table 2</i> .
26-Feb-2014	8	Updated: Section 4: Package mechanical data Inserted E _{AS} value on Table 2. Added value V _{GS} on Table 4

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